1. General description

Automotive qualified N-channel MOSFET using the latest Trench 9 low ohmic superjunction technology, housed in an enhanced LFPAK56E package. This product has been fully designed and qualified to meet AEC-Q101 requirements delivering high performance and endurance.

2. Features and benefits

- Fully automotive qualified to AEC-Q101:
 - 175 °C rating suitable for thermally demanding environments
- Trench 9 Superjunction technology:
 - Reduced cell pitch enables enhanced power density and efficiency with lower R_{DSon} in same footprint
 - Improved SOA and avalanche capability compared to standard TrenchMOS
 - Tight V_{GS(th)} limits enable easy paralleling of MOSFETs
- LFPAK Gull Wing leads:
 - High Board Level Reliability absorbing mechanical stress during thermal cycling, unlike traditional QFN packages
 - Visual (AOI) soldering inspection, no need for expensive x-ray equipment
 - · Easy solder wetting for good mechanical solder joint
- · LFPAK copper clip technology:
 - Improved reliability, with reduced R_{th} and R_{DSon}
 - Increases maximum current capability and improved current spreading

3. Applications

- 12 V automotive systems
- · Motors, lamps and solenoid control
- Start-Stop micro-hybrid applications
- · Transmission control
- · Ultra high performance power switching

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit	
V_{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C		-	-	40	V	
I _D	drain current	V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 2</u>	[1]	-	-	220	Α	
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 1</u>		-	-	500	W	
Static characte	Static characteristics							
R _{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_D = 25 A; T_j = 25 °C; Fig. 11		0.53	0.82	0.94	mΩ	



Symbol	Parameter	Conditions		Min	Тур	Max	Unit	
Dynamic chara	Dynamic characteristics							
Q_{GD}	gate-drain charge	$I_D = 25 \text{ A}; V_{DS} = 20 \text{ V}; V_{GS} = 4.5 \text{ V};$ Fig. 13; Fig. 14		-	12.7	25.3	nC	
Source-drain d	liode			•			•	
Q _r	recovered charge	I_S = 25 A; dI_S/dt = -100 A/ μ s; V_{GS} = 0 V; V_{DS} = 20 V; T_j = 25 °C	[2]	-	52.6	-	nC	
S	softness factor	I_S = 25 A; dI_S/dt = -100 A/ μ s; V_{GS} = 0 V; V_{DS} = 20 V; T_j = 25 °C; Fig. 17		-	0.77	-		

 ²²⁰A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source	ربومها	D
2	S	source	(\\-\\-\\\-\\\\\\\\\\\\\\\\\\\\\\\\\\\\	
3	S	source		G—(F)
4	G	gate		mbb076 S
mb	D	mounting base; connected to drain	1 2 3 4 LFPAK56E; Power- SO8 (SOT1023)	

6. Ordering information

Table 3. Ordering information

Type number	number Package					
	Name	Description	Version			
BUK9J0R9-40H	LFPAK56E; Power-SO8	plastic, single-ended surface-mounted package (LFPAK56); 4 leads; 1.27 mm pitch	SOT1023			

7. Marking

Table 4. Marking codes

Type number	Marking code
BUK9J0R9-40H	90H940E

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C	-	40	V
V_{GS}	gate-source voltage	DC; T _j ≤ 175 °C	-10	16	V

^[2] includes capacitive recovery

Symbol	Parameter	Conditions		Min	Max	Unit
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 1</u>		-	500	W
I _D	drain current	V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 2</u>	[1]	-	220	Α
		V _{GS} = 10 V; T _{mb} = 100 °C; <u>Fig. 2</u>	[1]	-	220	Α
I _{DM}	peak drain current	pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 \text{ °C}$; Fig. 3		-	600	Α
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
Source-drain	n diode					
Is	source current	T _{mb} = 25 °C	[2]	-	165	Α
I _{SM}	peak source current	pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 °C$		-	600	Α
Avalanche ru	uggedness		•			
E _{DS(AL)S}	non-repetitive drain- source avalanche energy	I_D = 160 A; $V_{sup} \le 40$ V; R_{GS} = 50 Ω; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; unclamped; Fig. 4	[3] [4]	-	290	mJ

- [1] 220A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.
- [2] 165A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.
- [3] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.
- [4] Refer to application note AN10273 for further information.

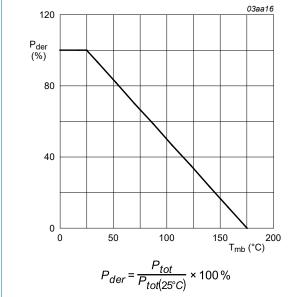
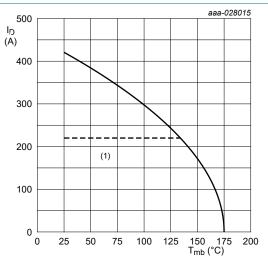


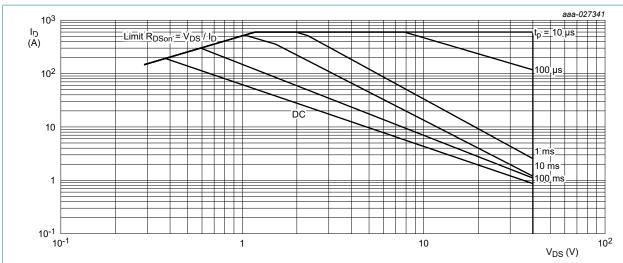
Fig. 1. Normalized total power dissipation as a function of mounting base temperature



 $V_{GS} \ge 10 \text{ V}$ (1) 220A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

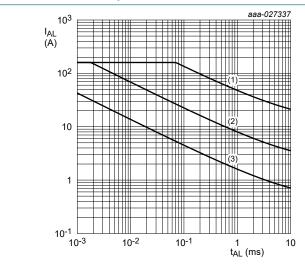
Fig. 2. Continuous drain current as a function of mounting base temperature

N-channel 40 V, 0.9 m Ω logic level MOSFET in LFPAK56E



T_{mb} = 25 °C; I_{DM} is a single pulse

Fig. 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage



(1) $T_{j \text{ (init)}} = 25 \text{ °C}$; (2) $T_{j \text{ (init)}} = 150 \text{ °C}$; (3) Repetitive Avalanche

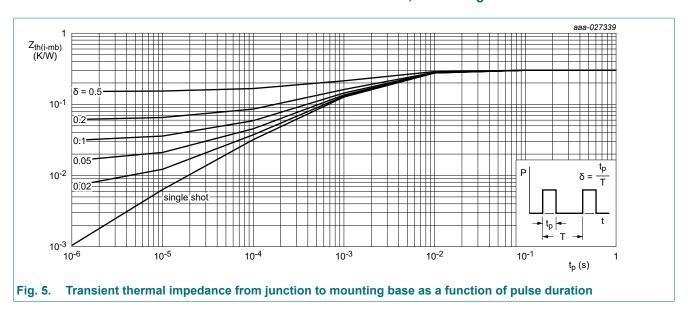
Fig. 4. Avalanche rating; avalanche current as a function of avalanche time

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	<u>Fig. 5</u>	-	0.21	0.3	K/W

N-channel 40 V, 0.9 m Ω logic level MOSFET in LFPAK56E



10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	acteristics					
V _{(BR)DSS}	drain-source	I _D = 250 μA; V _{GS} = 0 V; T _j = 25 °C	40	43	-	V
	breakdown voltage	I _D = 250 μA; V _{GS} = 0 V; T _j = -40 °C	-	40.5	-	V
		$I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55 °C$	36	40	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C}; Fig. 9;$ Fig. 10	1.35	1.66	2.05	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ Fig. 10	0.6	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C}; Fig. 10$	-	-	2.5	V
I _{DSS}	drain leakage current	V _{DS} = 40 V; V _{GS} = 0 V; T _j = 25 °C	-	0.4	5	μΑ
		V _{DS} = 16 V; V _{GS} = 0 V; T _j = 125 °C	-	3.2	25	μΑ
		V _{DS} = 40 V; V _{GS} = 0 V; T _j = 175 °C	-	405	1000	μΑ
I _{GSS}	gate leakage current	V _{GS} = 16 V; V _{DS} = 0 V; T _j = 25 °C	-	2	100	nA
		V _{GS} = -10 V; V _{DS} = 0 V; T _j = 25 °C	-	2	100	nA

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
R _{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_D = 25 A; T_j = 25 °C; Fig. 11		0.53	0.82	0.94	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 105 \text{ °C};$ Fig. 12		0.79	1.17	1.48	mΩ
		V_{GS} = 10 V; I_D = 25 A; T_j = 125 °C; Fig. 12		0.87	1.29	1.64	mΩ
		V_{GS} = 10 V; I_D = 25 A; T_j = 175 °C; Fig. 12		1.1	1.63	2.05	mΩ
		V_{GS} = 4.5 V; I_D = 25 A; T_j = 25 °C; Fig. 11		0.68	0.97	1.2	mΩ
		V_{GS} = 4.5 V; I_D = 25 A; T_j = 105 °C; Fig. 12		1	1.47	1.9	mΩ
		V_{GS} = 4.5 V; I_D = 25 A; T_j = 125 °C; Fig. 12		1.1	1.62	2.1	mΩ
		V_{GS} = 4.5 V; I_D = 25 A; T_j = 175 °C; Fig. 12		1.4	2.03	2.6	mΩ
R_G	gate resistance	f = 1 MHz; T _j = 25 °C		0.42	1.04	2.6	mΩ
Dynamic cl	haracteristics					'	1
Q _{G(tot)}	total gate charge	I _D = 25 A; V _{DS} = 20 V; V _{GS} = 10 V; Fig. 13; Fig. 14		-	120	168	nC
		I _D = 25 A; V _{DS} = 20 V; V _{GS} = 4.5 V;		-	54.2	76	nC
Q _{GS}	gate-source charge	Fig. 13; Fig. 14	1. 13; Fig. 14 = 25 A; V _{DS} = 20 V; V _{GS} = 4.5 V; 1. 13; Fig. 14	-	20.2	30.2	nC
Q _{GD}	gate-drain charge			-	12.7	25.3	nC
C _{iss}	input capacitance	ig. 11 'GS = 10 V; $I_D = 25$ A; $T_j = 105$ °C; ig. 12 'GS = 10 V; $I_D = 25$ A; $T_j = 125$ °C; ig. 12 'GS = 10 V; $I_D = 25$ A; $T_j = 175$ °C; ig. 12 'GS = 4.5 V; $I_D = 25$ A; $T_j = 175$ °C; ig. 11 'GS = 4.5 V; $I_D = 25$ A; $T_j = 105$ °C; ig. 11 'GS = 4.5 V; $I_D = 25$ A; $T_j = 105$ °C; ig. 12 'GS = 4.5 V; $I_D = 25$ A; $T_j = 175$ °C; ig. 12 'GS = 4.5 V; $I_D = 25$ A; $I_D = 175$ °C; ig. 12 = 1 MHz; $I_D = 175$ °C ig. 12 = 1 MHz; $I_D = 175$ °C ig. 13; Fig. 14 $I_D = 175$ °C; Fig. 15 $I_D = 175$ °C; Fig. 15 $I_D = 175$ °C; Fig. 16 $I_D = 175$ °C; Fig. 16 $I_D = 175$ °C; Fig. 17 $I_D = 175$ °C; Fig. 16 $I_D = 175$ °C; Fig. 17 $I_D = 175$ °C; Fig. 16 $I_D = 175$ °C; Fig. 17 $I_D = 175$ °C; Fig. 16 $I_D = 175$ °C; Fig. 16 $I_D = 175$ °C; Fig. 16 $I_D = 175$ °C; Fig. 17		-	8977	12568	pF
C _{oss}	output capacitance	T _j = 25 °C; <u>Fig. 15</u>		-	1549	2168	pF
C _{rss}	reverse transfer capacitance			-	346	760	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 20 \text{ V}; R_L = 0.8 \Omega; V_{GS} = 4.5 \text{ V};$		-	45.4	-	ns
t _r	rise time	$R_{G(ext)} = 5 \Omega$		-	46.2	-	ns
t _{d(off)}	turn-off delay time			-	59.2	-	ns
t _f	fall time			-	32.6	-	ns
Source-dra	in diode			'	_		
V _{SD}	source-drain voltage	$I_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}; Fig. 16$		-	0.76	1.2	V
t _{rr}	reverse recovery time	$I_S = 25 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = 0 \text{ V};$		-	44.6	-	ns
Q _r	recovered charge	V _{DS} = 20 V; T _j = 25 °C	[1]	-	52.6	-	nC
S	softness factor	I_S = 25 A; dI_S/dt = -100 A/ μ s; V_{GS} = 0 V; V_{DS} = 20 V; T_j = 25 °C; Fig. 17		-	0.77	-	
		I_S = 25 A; dI_S/dt = -500 A/ μ s; V_{GS} = 0 V; V_{DS} = 20 V; T_j = 25 °C; Fig. 17		-	0.67	-	

^[1] includes capacitive recovery

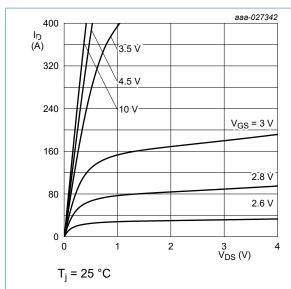


Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values

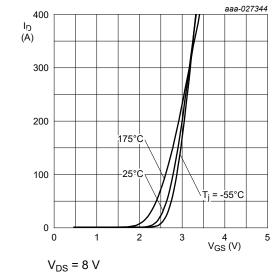


Fig. 8. Transfer characteristics; drain current as a function of gate-source voltage; typical values

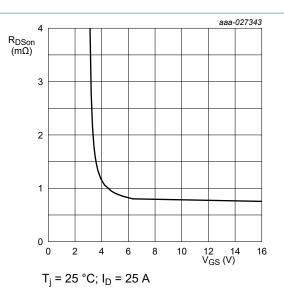


Fig. 7. Drain-source on-state resistance as a function of gate-source voltage; typical values

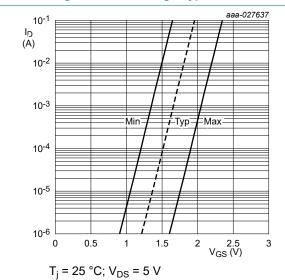


Fig. 9. Sub-threshold drain current as a function of gate-source voltage

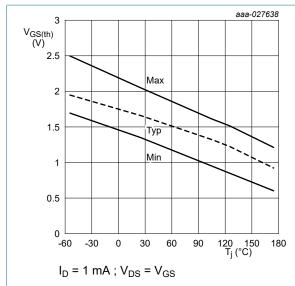


Fig. 10. Gate-source threshold voltage as a function of junction temperature

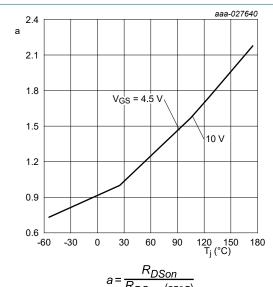


Fig. 12. Normalized drain-source on-state resistance factor as a function of junction temperature

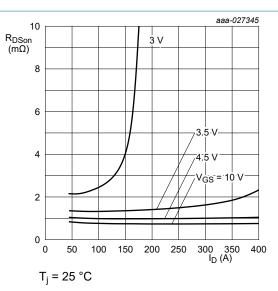


Fig. 11. Drain-source on-state resistance as a function of drain current; typical values

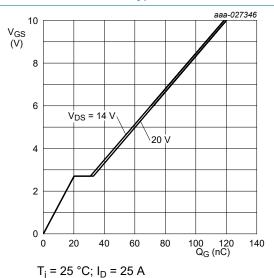


Fig. 13. Gate-source voltage as a function of gate charge; typical values

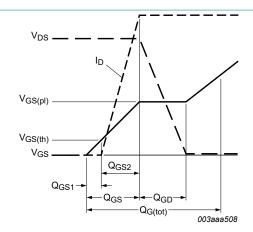


Fig. 14. Gate charge waveform definitions

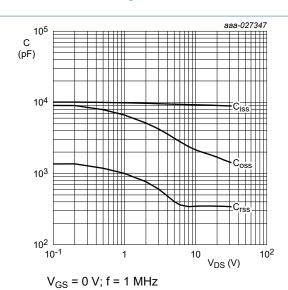


Fig. 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

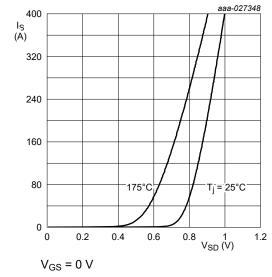


Fig. 16. Source-drain (diode forward) current as a function of source-drain (diode forward) voltage; typical values

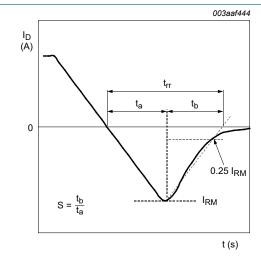


Fig. 17. Reverse recovery timing definition

11. Package outline

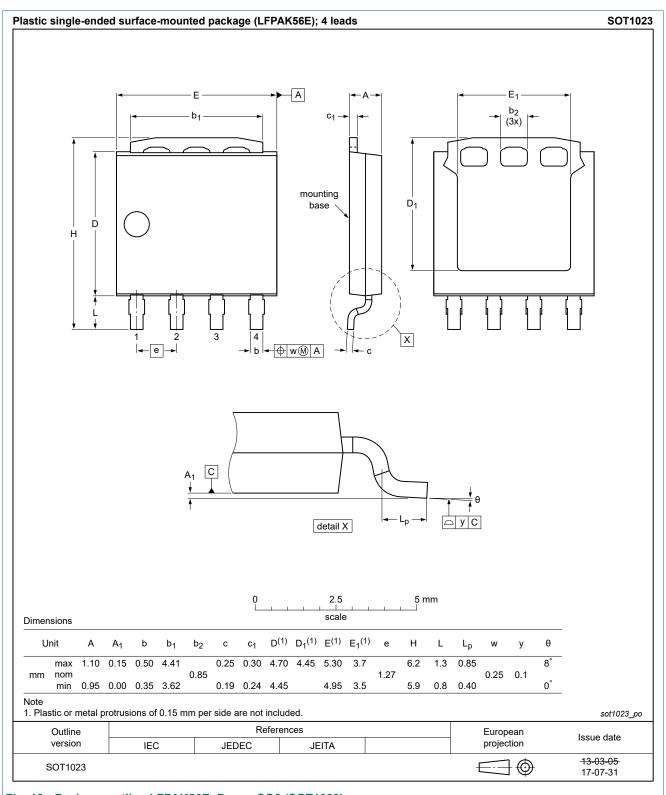


Fig. 18. Package outline LFPAK56E; Power-SO8 (SOT1023)

12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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